



RADIO TEST REPORT

Test Report No. : 27KE0187-HO-A-R1



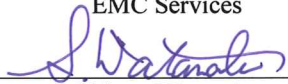


Applicant : SANYO Electric Co., Ltd.
Type of Equipment : WLAN Module
Model No. : QXXAVC922---P
FCC ID : NPKAVC922
Test standard : FCC Part 15 Subpart C 2007
Section 15.207, Section 15.247
Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. Original test report number of this report is 27KE0187-HO-A.

Date of test:

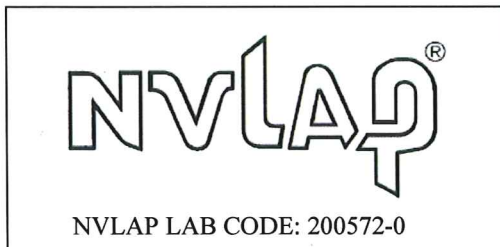
September 8 to October 5, 2007

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*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://uljapan.co.jp/emc/nvlap.htm>

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SECTION 1: Client information

Company Name : SANYO Electric Co., Ltd.
Address : 1-1 Sanyo-cho, Daito City, Osaka 574-8534, Japan
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Facsimile Number : +81-72-875-9358
Contact Person : Keiji Hirao

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : WLAN Module
Model No. : QXXAVC922---P
Serial No. : 1
Rating : DC3.3V
Country of Manufacture : Japan
Receipt Date of Sample : August 22, 2007
Condition of EUT : Production model
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No modification by the test lab.

2.2 Product Description

Model No: QXXAVC922---P (referred to as the EUT in this report) is the WLAN Module.

Clock frequency(ies) in the system : 40MHz
Equipment Type : Transceiver
Frequency of Operation : 2412-2462MHz
Bandwidth & Channel Spacing : 20MHz & 5MHz
Modulation : 11b: DSSS (DBPSK, DQPSK, CCK)
11g: OFDM (BPSK, QPSK, 16QAM, 64QAM)
Power Supply : DC3.3V
Antenna Type : Chip Dielectric Antenna
Antenna Connector Type : Chip Coaxial Connector (HSC)
Antenna Gain : 2.14 dBi (max)

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2007

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

FCC 15.31 (e)

As this EUT does not have a regulator, the supplied voltage depends on the installed device. Therefore the certification is limited only for the device which can provide voltage(DC3.3V) constantly.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the host device in which the EUT is installed. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.2	FCC: Section 15.207 IC: RSS-Gen 7.2.2	-	N/A	14.0dB 9.10800MHz, AV, N 9.94450MHz, AV, N	Complied
2	6dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) IC: RSS-210 A8.2(a)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.247 (d) IC: RSS-210 A8.5	Conducted Radiated	N/A		Complied
5	Power Density	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.247 (e) IC: RSS-210 A8.2(b)	Conducted	N/A		Complied
6	Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section 15.247(d) IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted Radiated	N/A		[Tx] 6.7dB 119.996MHz Vert., QP [Rx] 8.7dB 119.996MHz Vert., QP

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*These tests were also referred to "Guidance on Measurement of Digital Transmission Systems Operating under Section 15.247".

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor $k=2$.

Conducted Emission

The measurement uncertainty for this test is ± 2.66 dB.

The data listed in this test report has enough margin, more than the site margin.

Spurious Emission (Radiated)

The measurement uncertainty for this test using Biconical antenna is ± 4.59 dB(3m).

The measurement uncertainty for this test using Logperiodic antenna is ± 4.62 dB(3m).

The measurement uncertainty for this test using Horn antenna is ± 5.27 dB.

The data listed in this test report has enough margin, more than the site margin.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is ± 3.0 dB.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

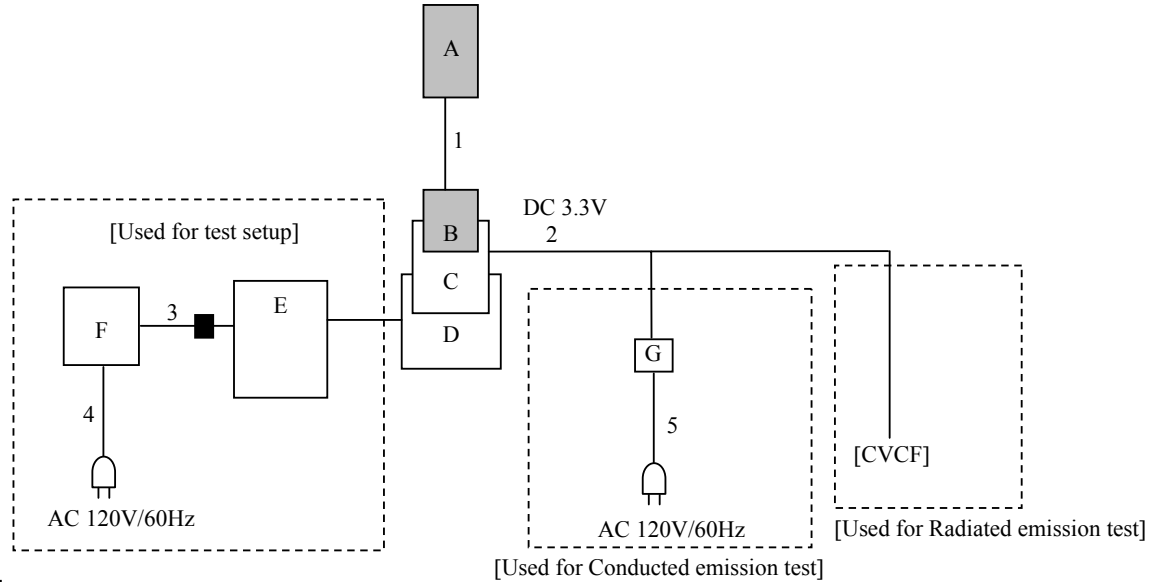
SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test	Mode	Tested frequency
Conducted emission Spurious Emission	IEEE802.11b Transmitting (Tx), 11Mbps	2412MHz
	IEEE802.11g Transmitting (Tx), 54Mbps	2437MHz 2462MHz
	----- IEEE802.11b/g Receiving (Rx)	2437MHz
6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	IEEE802.11b Transmitting (Tx), 11Mbps	2412MHz
	IEEE802.11g Transmitting (Tx), 54Mbps	2437MHz 2462MHz
Restricted Band Edge	IEEE802.11b Transmitting (Tx), 11Mbps	2412MHz
	IEEE802.11g Transmitting (Tx), 54Mbps	2462MHz
Transmitting duty was 100% on all tests.		

As a result of preliminary test, the formal test was performed with the above modes, which had the maximum rated power. (Refer to Maximum Peak Output Power)

4.2 Configuration and peripherals



■ : Standard Ferrite Core

* Cabling and setup were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Antenna Board	QXXAVC922-B	1	SANYO	EUT
B	WLAN Module	QXXAVC922---P	1	SANYO	EUT
C	Printed Circuit Board	-	-	SANYO	-
D	PC Card	-	J030602A	SANYO	-
E	Note PC	1952-D65	L3-DM297	lenovo	-
F	AC Adapter	92P1160	11S92P1160Z1ZBGH6B6DM7	lenovo	-
G	DC Power Supply	PW18-1.3AT	08016530	KENWOOD TMI	-

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	Antenna Cable	0.2	Unshielded	Unshielded
2	DC Cable	2.0 *1) 3.5 *2)	Unshielded	Unshielded
3	DC Cable	1.8	Unshielded	Unshielded
4	AC Cable	1.0	Unshielded	Unshielded
5	AC Cable	1.8	Unshielded	Unshielded

*1) Used for Conducted emission test.

*2) Used for Radiated emission test.

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Detector : quasi-peak and average detector (IF BW 9 kHz)
Measurement range : 0.15-30MHz
Test data : APPENDIX 2
Test result : Pass

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SECTION 6: Spurious Emission

[Conducted]

Test Procedure

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.

Test data : APPENDIX 2

Test result : Pass

[Radiated]

Test Procedure

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 2 of RSS-210 2.7 (IC) and outside the restricted band of FCC15.205 / Table 1 of RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver / Spectrum Analyzer	Spectrum Analyzer
Detector	QP: BW 120kHz(T/R)	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth	20dBc : RBW: 100kHz VBW: 300kHz (S/A)	AV: RBW:1MHz/VBW:10Hz 20dBc : RBW:100kHz/VBW:300kHz

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : APPENDIX 2

Test result : Pass

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SECTION 7: 6dB Bandwidth

Test Procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

Test data : APPENDIX 2
Test result : Pass

SECTION 8: Maximum Peak Output Power

Test Procedure

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.
It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

Test data : APPENDIX 2
Test result : Pass

SECTION 9: Peak Power Density

[Conducted]

Test Procedure

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.
It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

Test data : APPENDIX 2
Test result : Pass

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